

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

Y&T September 30, 2003

* Abstract provided for the Examiner's convenience

(Use several sheets if necessary)

Application No.:
10/706,075

Applicant:
Toshiaki NAKAMURA

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Group Art Unit:
2851

U.S. PATENT DOCUMENTS

[illegible]

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
/AB/	JP 2-5781	01/16/1990	JAPAN				
↓	JP 9-205527	08/05/1997	JAPAN				
	JP 62-65567	03/24/1987	JAPAN				
	JP 2002-77707	03/15/2002	JAPAN				
	JP 2002-325200	11/08/2002	JAPAN				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER: /Ali Bayat/

DATE CONSIDERED 04/20/2007

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